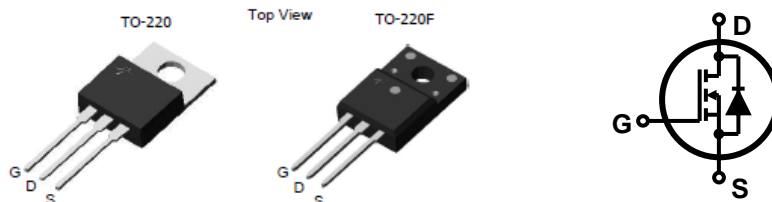


N-channel MOSFET

Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- Halogen free package
- JEDEC Qualification

BV_{DSS}	I_D	$R_{DS(on)}$
900V	4A	<4.0Ω



Device	Package	Marking	Remark
TMP4N90 / TMPF4N90	TO-220 / TO-220F	TMP4N90 / TMPF4N90	RoHS
TMP4N90G / TMPF4N90G	TO-220 / TO-220F	TMP4N90G / TMPF4N90G	Halogen Free

Absolute Maximum Ratings

Parameter	Symbol	TMP4N90(G)	TMPF4N90(G)	Unit	
Drain-Source Voltage	V_{DSS}	900		V	
Gate-Source Voltage	V_{GS}	±30		V	
Continuous Drain Current	I_D	$T_C = 25\text{ }^\circ\text{C}$	14	4 *	A
		$T_C = 100\text{ }^\circ\text{C}$	2.22	2.22 *	A
Pulsed Drain Current (Note 1)	I_{DM}	16	16 *	A	
Single Pulse Avalanche Energy (Note 2)	E_{AS}	8.5		mJ	
Repetitive Avalanche Current (Note 1)	I_{AR}	4		A	
Repetitive Avalanche Energy (Note 1)	E_{AR}	12.3		mJ	
Power Dissipation	P_D	$T_C = 25\text{ }^\circ\text{C}$	123	38.7	W
		Derate above 25 °C	0.98	0.30	W/°C
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5		V/ns	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150		°C	
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	300		°C	

* Limited only by maximum junction temperature

Thermal Characteristics

Parameter	Symbol	TMP4N90(G)	TMPF4N90(G)	Unit
Maximum Thermal resistance, Junction-to-Case	$R_{\theta JC}$	1.01	3.23	°C/W
Maximum Thermal resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	62.5	°C/W

Electrical Characteristics : $T_C=25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test condition	Min	Typ	Max	Units
OFF						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	900	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 900\text{ V}, V_{GS} = 0\text{ V}$	--	--	10	μA
		$V_{DS} = 720\text{ V}, T_C = 125^\circ\text{C}$	--	--	100	μA
Forward Gate-Source Leakage Current	I_{GSSF}	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
Reverse Gate-Source Leakage Current	I_{GSSR}	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA

ON						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2	--	4	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 2\text{ A}$	--	3.2	4.0	Ω
Forward Transconductance ^(Note 4)	g_{FS}	$V_{DS} = 30\text{ V}, I_D = 2\text{ A}$	--	6	--	S

DYNAMIC						
Input Capacitance	C_{iss}	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	955	--	pF
Output Capacitance	C_{oss}		--	80	--	pF
Reverse Transfer Capacitance	C_{rss}		--	13	--	pF

SWITCHING						
Turn-On Delay Time ^(Note 4,5)	$t_{d(on)}$	$V_{DD} = 450\text{ V}, I_D = 4\text{ A},$ $R_G = 25\ \Omega$	--	49	--	ns
Turn-On Rise Time ^(Note 4,5)	t_r		--	38	--	ns
Turn-Off Delay Time ^(Note 4,5)	$t_{d(off)}$		--	146	--	ns
Turn-Off Fall Time ^(Note 4,5)	t_f		--	50	--	ns
Total Gate Charge ^(Note 4,5)	Q_g	$V_{DS} = 720\text{ V}, I_D = 4\text{ A},$ $V_{GS} = 10\text{ V}$	--	25	--	nC
Gate-Source Charge ^(Note 4,5)	Q_{gs}		--	4.8	--	nC
Gate-Drain Charge ^(Note 4,5)	Q_{gd}		--	10.2	--	nC

SOURCE DRAIN DIODE						
Maximum Continuous Drain-Source Diode Forward Current	I_S	---	--	--	4	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}	---	--	--	16	A
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = 4\text{ A}$	--	--	1.5	V
Reverse Recovery Time ^(Note 4)	t_{rr}	$V_{GS} = 0\text{ V}, I_S = 4\text{ A}$	--	487	--	ns
Reverse Recovery Charge ^(Note 4)	Q_{rr}	$di_F / dt = 100\text{ A}/\mu\text{s}$	--	2.8	--	μC

- Note :
1. Repeated rating : Pulse width limited by safe operating area
 2. $L=1\text{mH}, I_{AS} = 4\text{A}, V_{DD} = 50\text{V}, R_G = 25\ \Omega$, Starting $T_J = 25^\circ\text{C}$, not subject to production test – verified by design/characterization
 3. $I_{SD} \leq 4\text{A}, di/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq BV_{DS}$, Starting $T_J = 25^\circ\text{C}$
 4. Pulse Test : Pulse width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2\%$
 5. Essentially Independent of Operating Temperature Typical Characteristics

Fig. 1 Output Characteristics

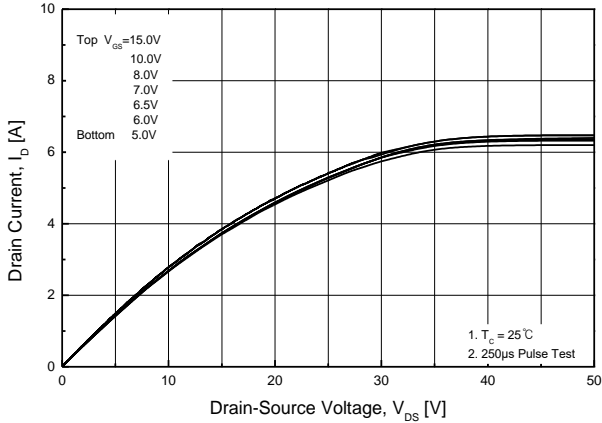


Fig. 2 Transfer Characteristics

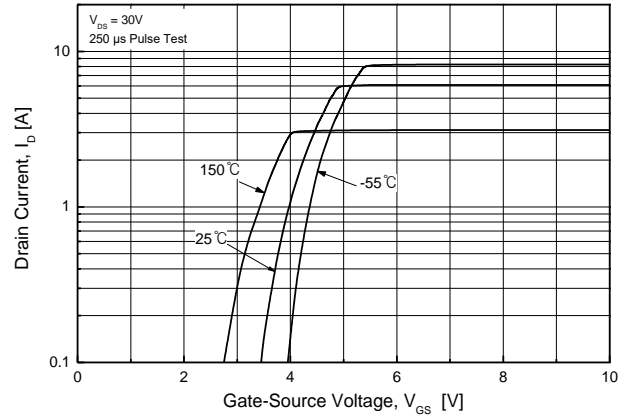


Fig. 3 On-Resistance vs. Drain Current and Gate voltage

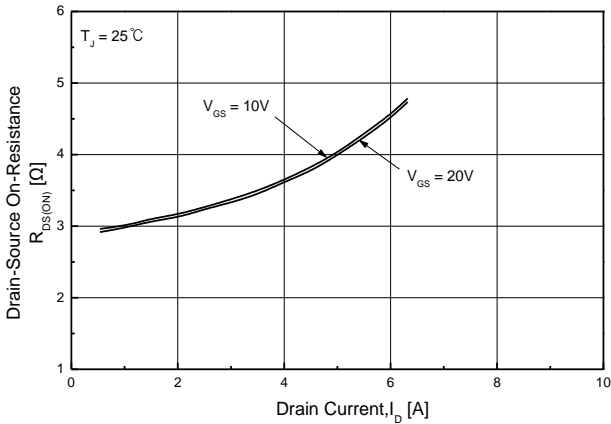


Fig. 4 Body Diode Forward Voltage vs. Source Current and Temperature

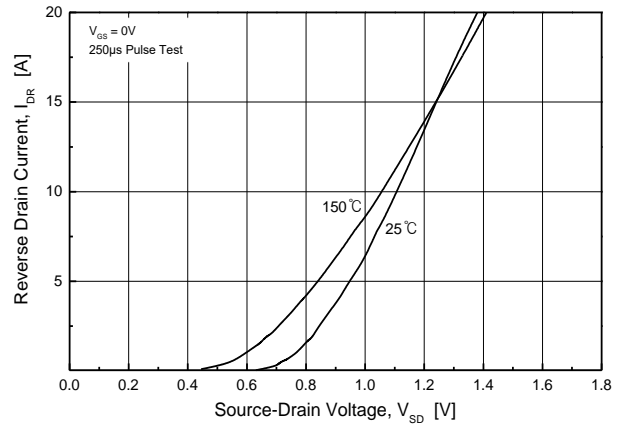


Fig. 5 Capacitance Characteristics

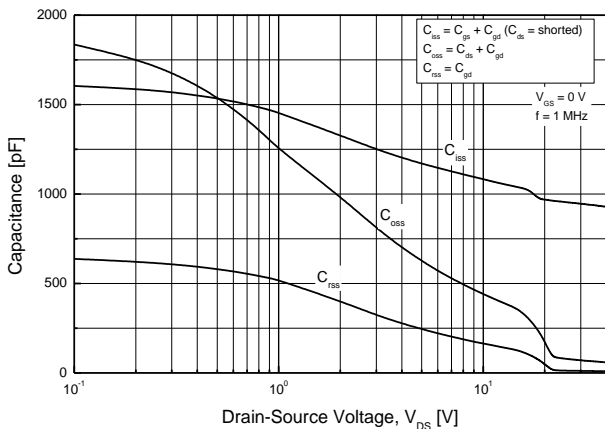


Fig. 6 Gate Charge Characteristics

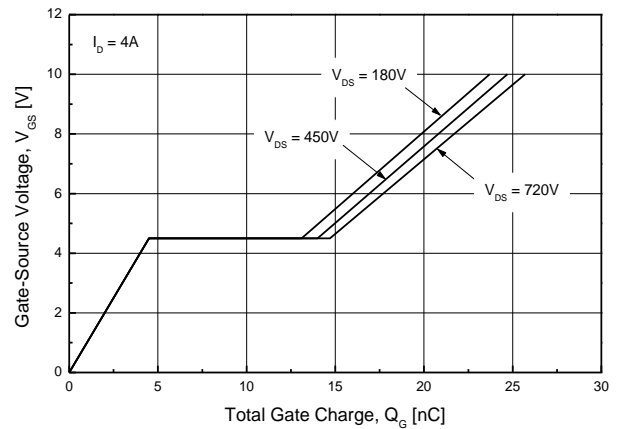


Fig. 7 Breakdown Voltage vs. Temperature

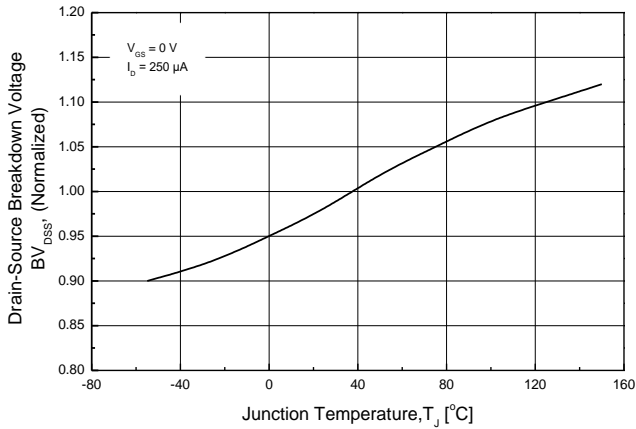


Fig. 8 On-Resistance vs. Temperature

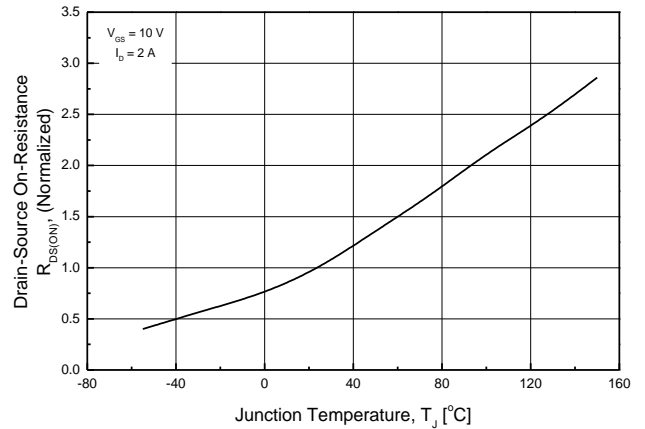


Fig. 9 Maximum Drain Current vs. Case Temperature

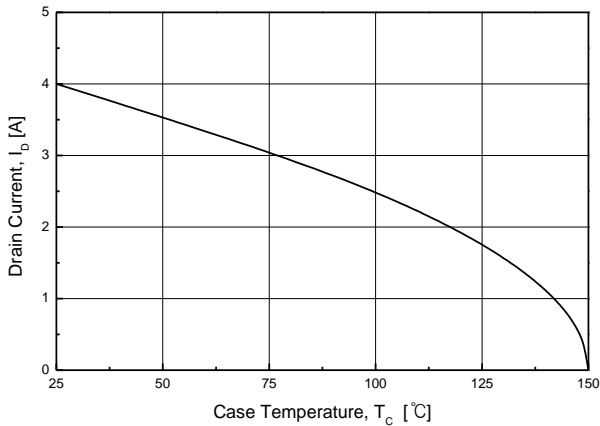


Fig. 10 Gate Threshold Voltage vs. Junction Temperature

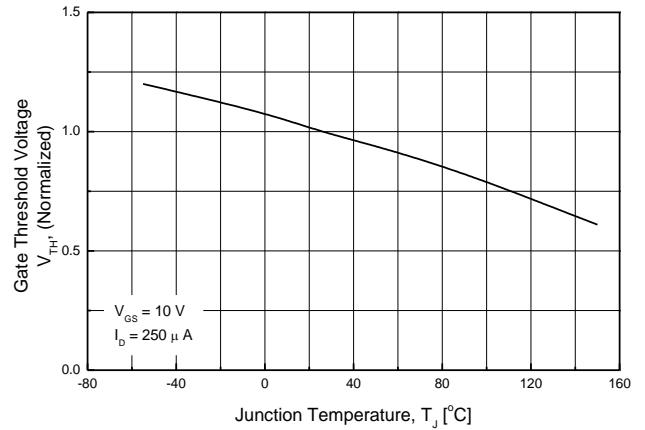


Fig. 11 Maximum Safe Operating Area

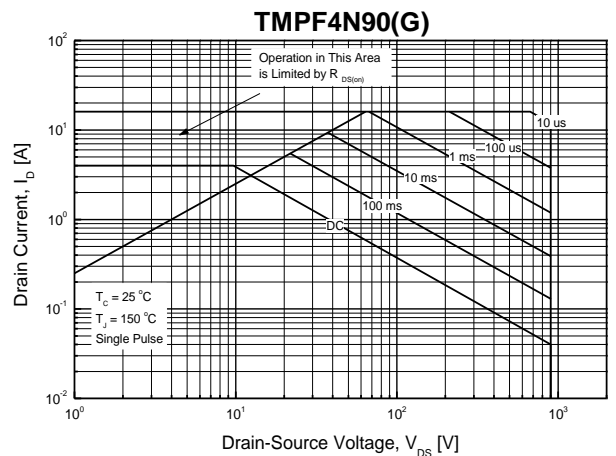
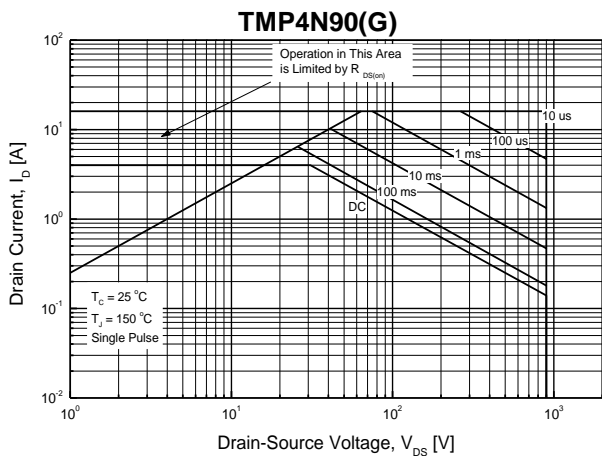
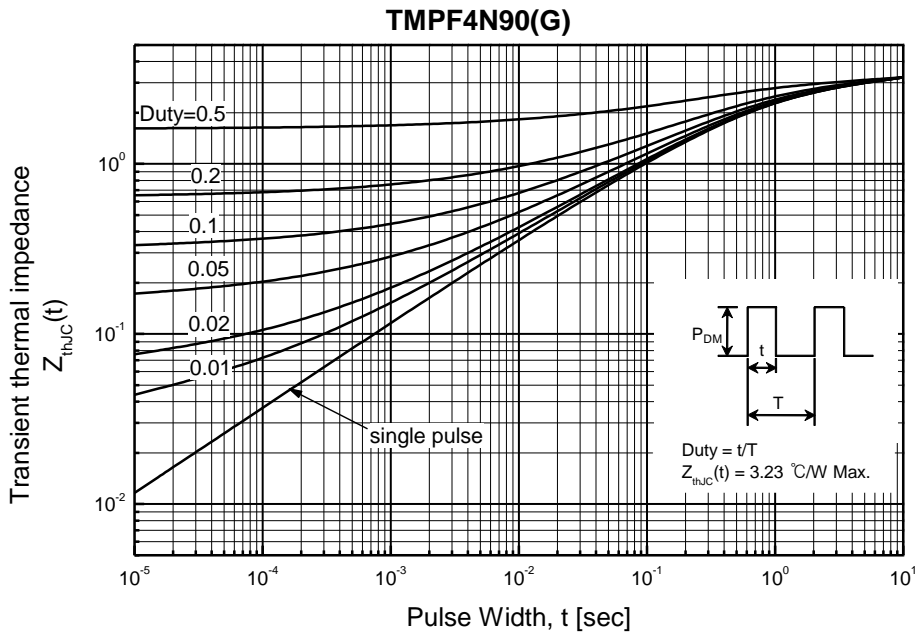
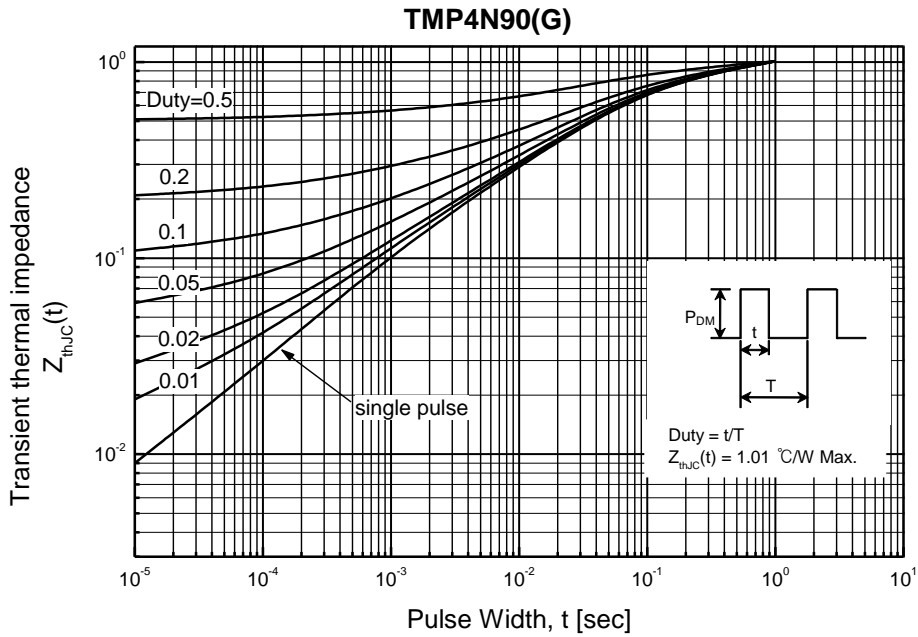
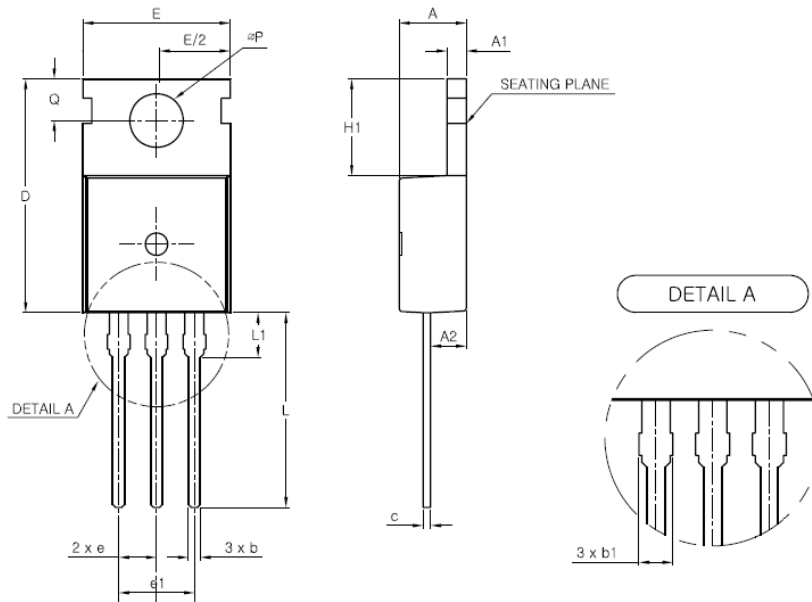
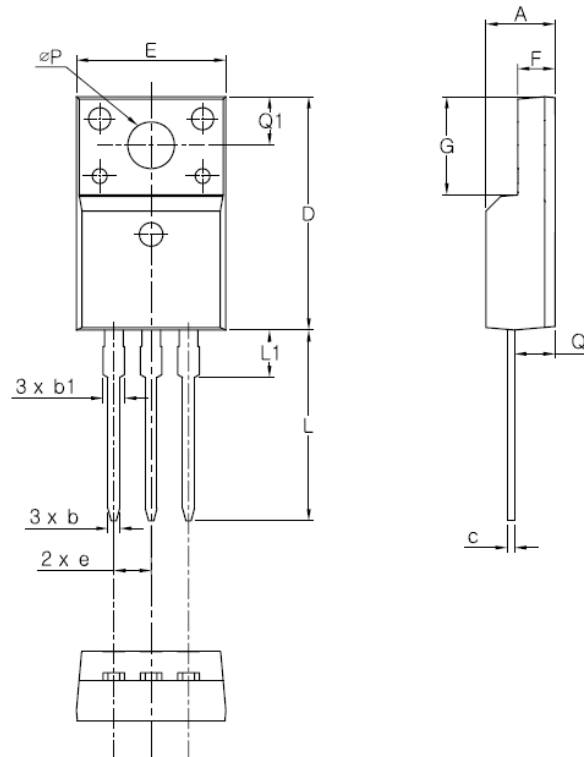


Fig. 12 Transient Thermal Response Curve



TO-220AB-3L MECHANICAL DATA


SYMBOL	MIN	MAX
A	4.30	4.70
A1	1.22	1.40
A2	2.20	2.79
b	0.70	0.91
b1	1.15	1.62
c	0.36	0.60
D	14.99	15.90
E	9.70	10.41
e	2.54 TYP	
e1	5.08 BSC	
H1	5.97	6.70
L	12.88	13.97
L1	3.31	3.81
ØP	3.40	3.88
Q	2.60	2.90

TO-220F-3L MECHANICAL DATA


SYMBOL	MIN	MAX
A	4.50	4.93
b	0.70	0.91
b1	1.15	1.47
c	0.36	0.60
D	15.67	16.07
E	6.96	10.36
e	2.54 BSC	
F	2.34	2.74
G	6.48	6.90
L	12.37	13.18
L1	2.23	3.43
Q	2.56	2.96
Q1	3.10	3.50
ØP	2.98	3.38

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